

Notice of References Cited	Application/Control No. 10/500,543		Applicant(s)/Patent Under Reexamination SCHOTTEK ET AL.	
	Examiner RIP A. LEE		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,191,294 B1	02-2001	Resconi et al.	556/11
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 02/083699 A2	10-2002	International	Resconi et al.	C07F 17/00
	O	WO 00/75151 A1	12-2000	International	Resconi et al.	C07F 17/00
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NON-PATENT DOCUMENTS

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	U	Balboni et al. Inorg. Chem. 2001, 40, 6588-6597.
	V	Resconi et al. Organometallics, 2000, 19, 420-429.
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.